

P-channel 30 V, 0.16 Ω typ., 7 A, STripFET™ II Power MOSFET in a SO-8 package

Datasheet - production data

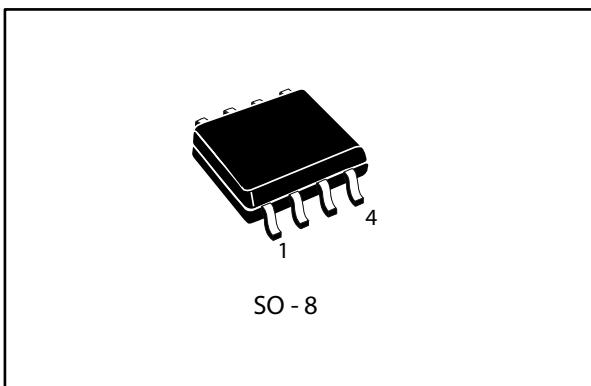
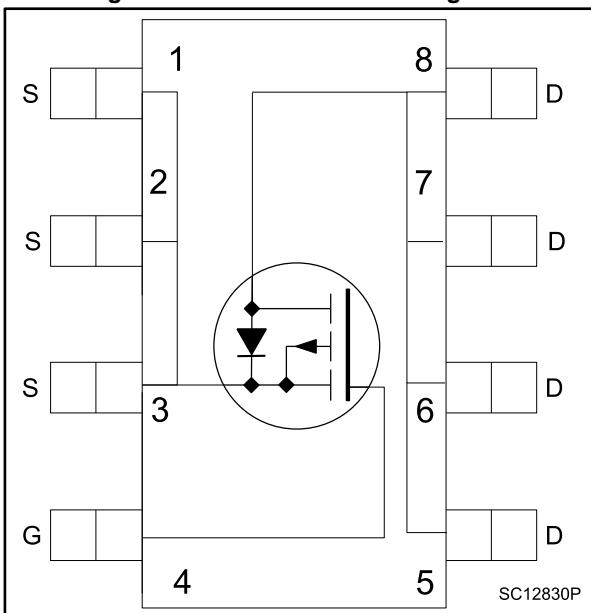


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D
STS7PF30L	30 V	0.021 Ω	7 A

- Standard outline for easy automated surface mount assembly
- Low threshold drive

Applications

- Switching applications

Description

This Power MOSFET series realized with STMicroelectronics unique STripFET™ process is specifically designed to minimize input capacitance and gate charge. It is therefore ideal as a primary switch in advanced high-efficiency isolated DC-DC converters for Telecom and Computer applications. It is also suitable for any application with low gate charge drive requirements.

Table 1: Device summary

Order code	Marking	Package	Packaging
STS7PF30L	7PF30L	SO-8	Tape and reel

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	30	V
V_{GS}	Gate-source voltage	± 20	V
V_{DGR}	Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)	30	V
I_D	Drain current (continuous) at $T_{amb} = 25^\circ\text{C}$	7	A
I_D	Drain current (continuous) at $T_{amb} = 100^\circ\text{C}$	4.4	A
$I_{DM}^{(1)}$	Drain current (pulsed)	28	A
P_{TOT}	Total dissipation at $T_{amb} = 25^\circ\text{C}$	2.5	W
T_{stg}	Storage temperature range	-55 to 150	$^\circ\text{C}$
T_j	Operating junction temperature range		$^\circ\text{C}$

Notes:

(1) Pulse width limited by safe operating area.

Table 3: Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-amb}^{(1)}$	Thermal resistance junction-amb	50	$^\circ\text{C/W}$

Notes:(1) When mounted on 1 inch² FR-4 board, 2 oz. Cu., t ≤ 10 s

For the P-channel Power MOSFET, current polarity of voltages and current have to be reversed.

2 Electrical characteristics

($T_C = 25^\circ\text{C}$ unless otherwise specified)

Table 4: Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
$I_{\text{DS}(\text{SS})}$	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}$			1	μA
		$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, T_C = 125^\circ\text{C}$ ⁽¹⁾			10	μA
I_{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 16 \text{ V}$			± 100	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	1	1.6	2.5	V
$R_{DS(\text{on})}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 3.5 \text{ A}$	0.011	0.016	0.021	Ω
		$V_{GS} = 4.5 \text{ V}, I_D = 3.5 \text{ A}$	0.016	0.022	0.028	

Notes:

⁽¹⁾Defined by design, not subject to production test.

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
g_{fs}	Forward transconductance	$V_{DS} = 20 \text{ V}, I_D = 3.5 \text{ A}$	-	16		S
C_{iss}	Input capacitance		-	2600		pF
C_{oss}	Output capacitance		-	523		pF
C_{rss}	Reverse transfer capacitance		-	174		pF
Q_g	Total gate charge		-	28	38	nC
Q_{gs}	Gate-source charge		-	8.75		nC
Q_{gd}	Gate-drain charge		-	12.35		nC

Table 6: Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 15 \text{ V}, I_D = 3.5 \text{ A}$	-	68	-	ns
t_r	Rise time	$R_G = 4.7 \Omega, V_{GS} = 4.5 \text{ V}$	-	54	-	ns
$t_{d(off)}$	Turn-off-delay time	(see Figure 14: "Switching times test circuit for resistive load")	-	65	-	ns
t_f	Fall time		-	23	-	ns

 For the P-channel Power MOSFET, current polarity of voltages and current have to be reversed.

Table 7: Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain current		-		7	A
I_{SDM}	Source-drain current (pulsed)		-		28	A
$V_{SD}^{(1)}$	Forward on voltage	$V_{GS} = 0 \text{ V}, I_{SD} = 7 \text{ A}$	-		1.2	V
t_{rr}	Reverse recovery time		-	40		ns
Q_{rr}	Reverse recovery charge	$I_{SD} = 7 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 15 \text{ V}, T_j = 150 \text{ }^\circ\text{C}$ (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	46		nC
I_{RRM}	Reverse recovery current		-	2.3		A

Notes:

⁽¹⁾Pulse test: pulse duration = 300 μs , duty cycle 1.5%



For the P-channel Power MOSFET, current polarity of voltages and current have to be reversed.

2.2 Electrical characteristics (curves)

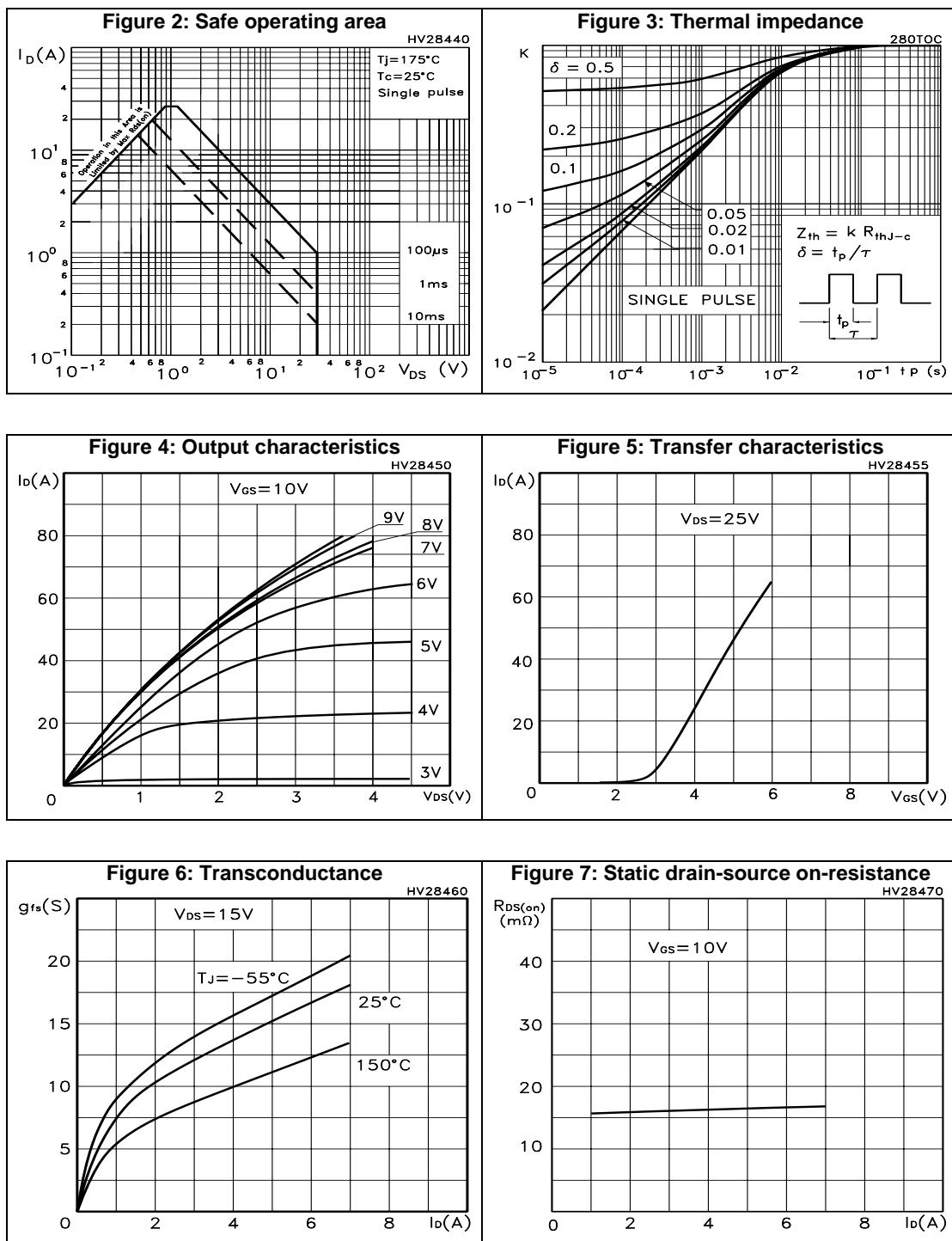
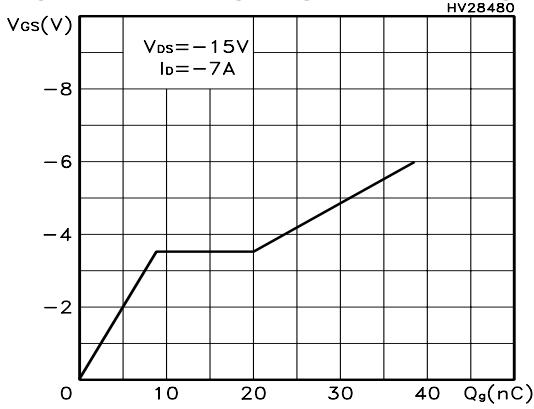
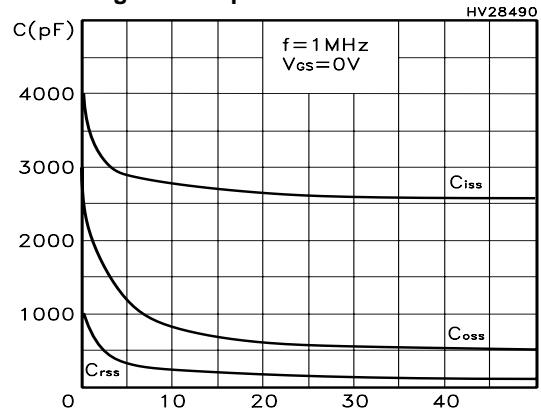
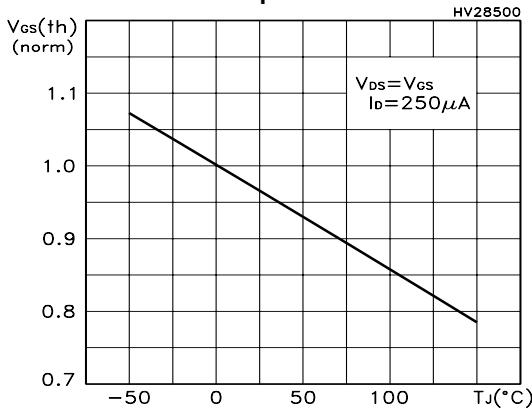
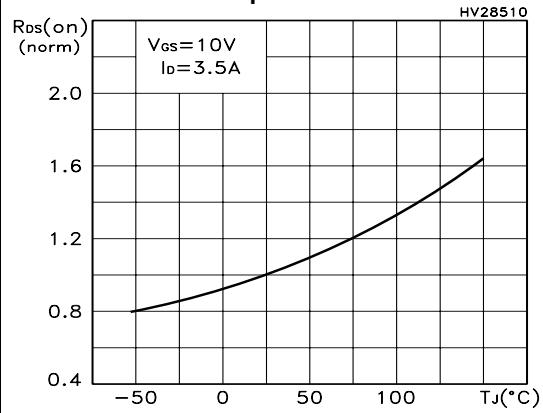
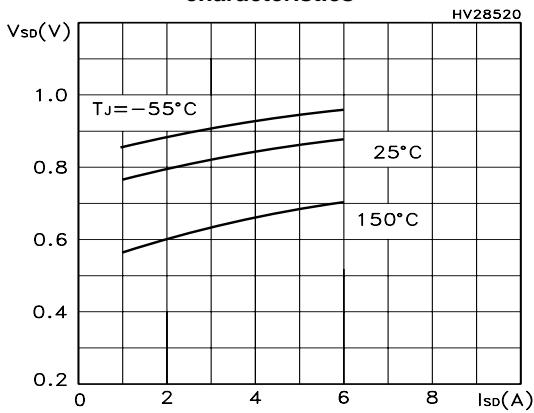
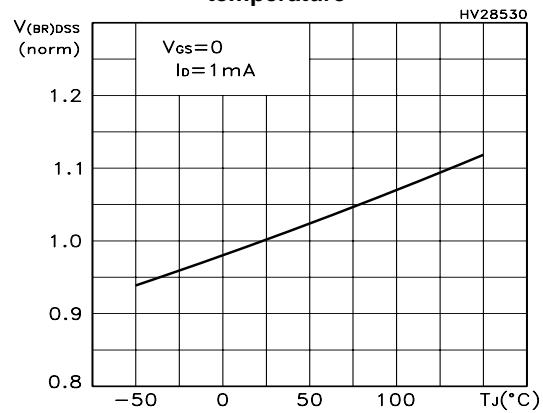


Figure 8: Gate charge vs gate-source voltage**Figure 9: Capacitance variations****Figure 10: Normalized gate threshold voltage vs temperature****Figure 11: Normalised on-resistance vs temperature****Figure 12: Source-drain diode forward characteristics****Figure 13: Normalised breakdown voltage vs temperature**

3 Test circuits

Figure 14: Switching times test circuit for resistive load

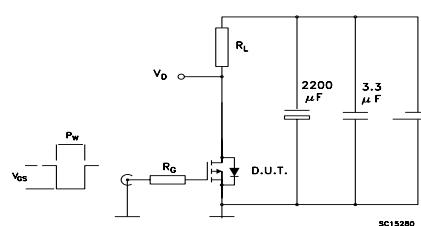


Figure 15: Gate charge test circuit

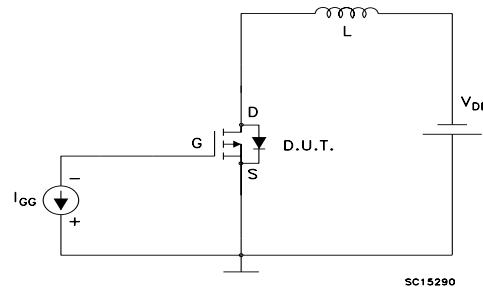
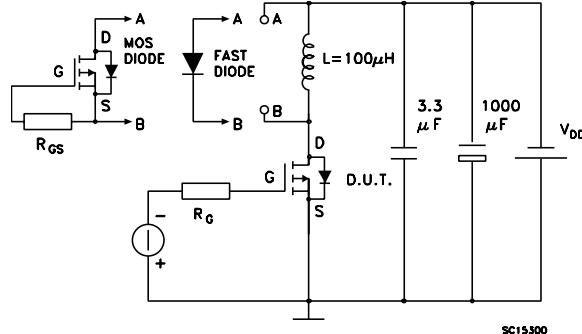


Figure 16: Test circuit for inductive load switching and diode recovery times



4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 SO-8 package information

Figure 17: SO-8 package outline

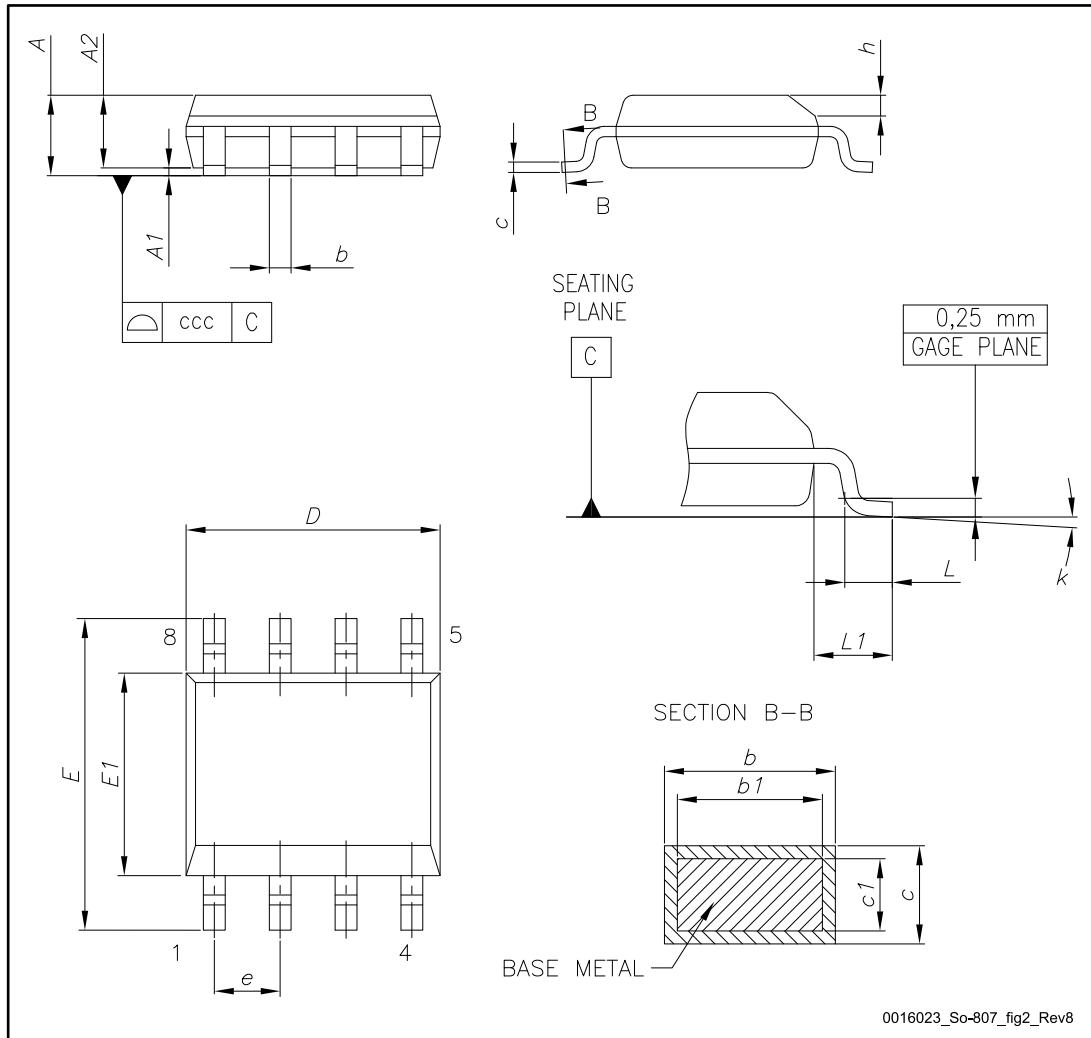
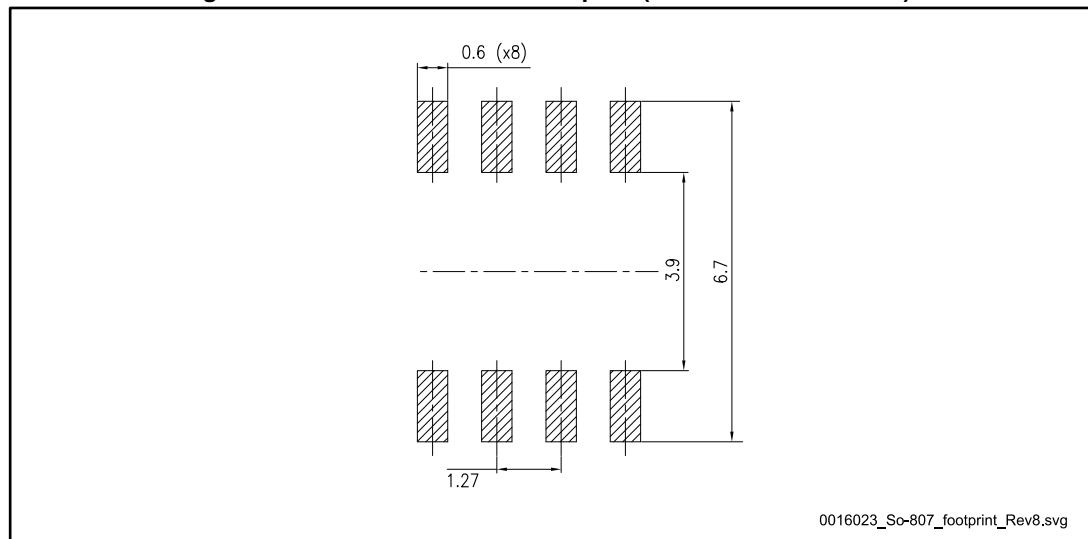


Table 8: SO-8 mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A			1.75
A1	0.10		0.25
A2	1.25		
b	0.31		0.51
b1	0.28		0.48
c	0.10		0.25
c1	0.10		0.23
D	4.80	4.90	5.00
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
e		1.27	
h	0.25		0.50
L	0.40		1.27
L1		1.04	
L2		0.25	
k	0°		8°
ccc			0.10

Figure 18: SO-8 recommended footprint (dimensions are in mm)



4.2 Packing information

Figure 19: SO-8 tape and reel dimensions

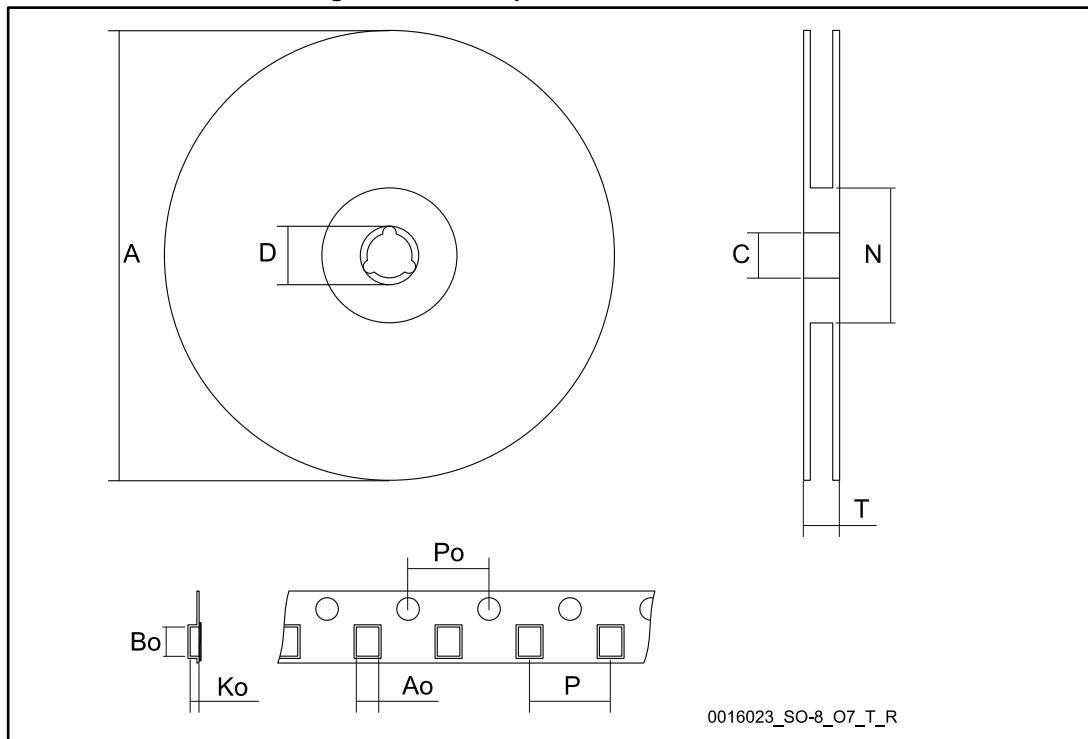


Table 9: SO-8 tape and reel mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A			330
C	12.8		13.2
D	20.2		
N	60		
T			22.4
Ao	8.1		8.5
Bo	5.5		5.9
Ko	2.1		2.3
Po	3.9		4.1
P	7.9		8.1

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
13-Dec-2003	1	First revision.
25-Jun-2004	2	Preliminary data.
18-Jan-2005	3	Modified value on Table 6.
29-Sep-2005	4	Complete version.
09-nov-2005	5	The document has been reformatted.
22-Feb-2016	6	Modified: <i>Table 1: "Device summary"</i> in cover page Modified: <i>Table 4: "Static"</i> Minor text changes

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